

## Assignment #12

Due on Friday, November 13, 2009

Read Section 6.3 on *Maximum Likelihood Tests*, pp. 333–339, in Hogg, Craig and McKean.

Do the following problems

1. Suppose that you observe  $n$  iid Bernoulli( $p$ ) random variables, denoted by  $X_1, X_2, \dots, X_n$ . Find the LRT rejection region for the test of  $H_0: p \leq p_o$  versus  $H_1: p > p_o$  in terms of the test statistic  $Y = \sum_{i=1}^n X_i$ .
2. Consider the likelihood ratio test for  $H_0: p = p_o$  versus  $H_1: p = p_1$ , where  $p_o \neq p_1$ , based on a random sample  $X_1, X_2, \dots, X_n$  from a Bernoulli( $p$ ) distribution for  $0 < p < 1$ . Show that, if  $p_1 > p_o$ , then the likelihood ratio statistic for the test is a monotonically decreasing function of  $Y = \sum_{i=1}^n X_i$ . Conclude, therefore, that if the test rejects  $H_0$  at the significance level  $\alpha$  for an observed value  $\hat{y}$  of  $Y$ , it will also reject  $H_0$  at that level for  $Y > \hat{y}$ .
3. We wish to use an LRT to test the hypothesis  $H_0: \mu = \mu_o$  against the alternative  $H_1: \mu \neq \mu_o$  based on a random sample,  $X_1, X_2, \dots, X_n$ , from a normal( $\mu, 1$ ) distribution.
  - (a) Give the maximum likelihood estimator,  $\hat{\mu}$ , for  $\mu$  based on the sample.
  - (b) Give the likelihood ratio statistic for the test.
  - (c) Express the LRT rejection region in terms of the sample mean  $\bar{X}_n$ .
4. Let  $X_1, X_2, \dots, X_n$  denote a random sample from a uniform( $0, \theta$ ) distribution for some parameter  $\theta > 0$ .
  - (a) Give the likelihood function  $L(\theta | x_1, x_2, \dots, x_n)$ .
  - (b) Give the maximum likelihood estimator for  $\theta$ .

5. Let  $R$  denote the rejection region for an LRT of  $H_0: \theta = \theta_0$  versus  $H_1: \theta = \theta_1$  based on a random sample,  $X_1, X_2, \dots, X_n$ , from continuous distribution with pdf  $f(x | \theta)$ . Let  $L(\theta | x_1, x_2, \dots, x_n)$  denote the likelihood function. Suppose the LRT has significance level  $\alpha$ .

- (a) Explain why

$$\alpha = \int_R L(\theta_0 | x_1, x_2, \dots, x_n) dx_1 dx_2 \cdots dx_n.$$

- (b) Explain why the power of the test is

$$\gamma(\theta_1) = \int_R L(\theta_1 | x_1, x_2, \dots, x_n) dx_1 dx_2 \cdots dx_n.$$

- (c) Explain why

$$\alpha \leq c\gamma(\theta_1),$$

where  $c$  is the critical value used in the definition of the rejection region,  $R$ , for the LRT.